CMA16N50



500V N-Channel MOSFET

General Description

These N-Channel enhancement mode power field effect transistors are produced using advanced technology which has been especially tailored to minimize on-state resistance, provide superior switching performance, and withstand high energy pulse in the avalanche and commutation mode. These devices are well suited for high efficient switched mode power supplies and active power factor correction.

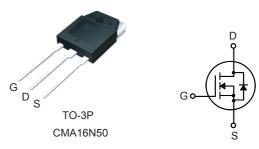
Product Summary

BVDSS	RDSON	ID
500V	0.37Ω	16A

Applications

- DC-DC converters
- Switching regulators
- UPS (Uninterruptible Power Supply)

TO-3P Pin Configuration



Features

- 100% avalanche tested
- Fast Switching
- Improved dv/dt capability

Absolute Maximum Ratings

Symbol	Parameter	Rating	Units	
V _{DS}	Drain-Source Voltage	500	V	
V _{GS}	Gate-Source Voltage	±30	V	
I₀@T₀=25℃	Continuous Drain Current 16		А	
I _D @T _C =100℃	Continuous Drain Current	9.6	А	
I _{DM}	Pulsed Drain Current ¹ 64		А	
EAS	Single Pulse Avalanche Energy ²	960	mJ	
P₀@T₀=25℃	Total Power Dissipation 200		W	
T _{STG}	Storage Temperature Range -55 to 150		°C	
TJ	Operating Junction Temperature Range -55 to 150		°C	

Thermal Data

Symbol	Parameter	Тур. Мах.		Unit	
R _{θJA}	Thermal Resistance Junction-ambient		40	°C/W	
R _{θJC}	Thermal Resistance Junction-case		0.6	°C/W	



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Electrical Characteristics (T_J=25 $^\circ\!\!\mathbb{C}$, unless otherwise noted)

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit
BV _{DSS}	Drain-Source Breakdown Voltage	V_{GS} =0V , I _D =250uA	500			V
$\triangle BV_{DSS} / \triangle T_J$	BVDSS Temperature Coefficient	Reference to 25 $^\circ\!\!{\rm C}$, I_D=250uA		0.6		V/℃
R _{DS(ON)}	Static Drain-Source On-Resistance	V_{GS} =10V , I _D =8A			0.37	Ω
V _{GS(th)}	Gate Threshold Voltage	V_{GS} = V_{DS} , I_D =250 μ A	2		4	V
	Drain Course Lookana Current	V _{DS} =500V, V _{GS} =0V			1	
I _{DSS}	Drain-Source Leakage Current	V _{DS} =400V , V _{GS} =0V , TC=125℃			10	uA
I _{GSS}	Gate-Source Leakage Current	$V_{GS} = \pm 30V$, $V_{DS} = 0V$			±100	nA
gfs	Forward Transconductance ³	V _{DS} =20V , I _D =8A		15		S
Qg	Total Gate Charge	ID=16A		45		
Q _{gs}	Gate-Source Charge	V _{DS} =400V		12		nC
Q _{gd}	Gate-Drain Charge	V _{GS} =10V (Note 3, 4)		20		1
T _{d(on)}	Turn-On Delay Time	V _{DS} =250V		50		
Tr	Rise Time	ID=16A		170		20
T _{d(off)}	Turn-Off Delay Time	R _G =25Ω		95		ns
T _f	Fall Time	(Note 3, 4)		80		
C _{iss}	Input Capacitance			4200		
C _{oss}	Output Capacitance	V _{DS} =25V , V _{GS} =0V , f=1MHz		350		pF
Crss	Reverse Transfer Capacitance			35		

Diode Characteristics

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit
Is	Continuous Source Current	$-V_G=V_D=0V$, Force Current			16	А
I _{SM}	Pulsed Source Current				64	А
V _{SD}	Diode Forward Voltage	V _{GS} =0V , I _S =16A , TJ=25℃			1.4	V

Note :

1.Repetitive Rating: Pulse width limited by maximum junction temperature

2.L = 7.5mH, IAS = 16A, VDD = 50V, RG = 25 Ω , Starting TJ = 25 $^\circ\!\!\mathbb{C}$

3.Pulse Test: Pulse width≤300µs, Duty Cycle≤2%

4. Essentially Independent of Operating Temperature Typical Characteristics

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